

**Search Notes**

Application/Control No.

10/757,204

Examiner

Sang Nguyen

Applicant(s)/Patent under  
Reexamination

KE ET AL.

Art Unit

2877

**SEARCHED**

Class	Subclass	Date	Examiner
UP DATE	Searched the same on 6/9/06	11/12/2006	SN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR